	Application No.	Applicant(s)	
Notice of Allowability	10/625,238	XUE, YALEI	
	Examiner	Art Unit	
	Jean F. Duverne	2839	
The MAILING DATE of this communication app All claims being allowable, PROSECUTION ON THE MERITS In herewith (or previously mailed), a Notice of Allowance (PTOL-8: NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT In of the Office or upon petition by the applicant. See 37 CFR 1.37	S (OR REMAINS) CLOSED i 5) or other appropriate comm RIGHTS. This application is	n this application. If not included unication will be mailed in due course. THIS	
1. 🔀 This communication is responsive to application filed on	7/22/2003.		
2. The allowed claim(s) is/are 6-15.			
3. \boxtimes The drawings filed on $\underline{7/22/2003}$ are accepted by the Exa	ıminer.		
4. Acknowledgment is made of a claim for foreign priority (a) All b) Some* c) None of the: 1. Certified copies of the priority documents have 2. Certified copies of the priority documents have 3. Copies of the certified copies of the priority documents have 1. Copies of the certified copies of the priority documents have 1. Certified copies of the certified copies of the priority documents have 1. Certified copies of the certified copies of the priority documents have 1. Certified copies of the certified copies of the priority documents have 1. Certified copies of the certified copies of the priority documents have 1. Certified copies of the certified copies of the priority documents have 1. Certified copies have 1. Certifi	ve been received. ve been received in Application	on No	
Applicant has THREE MONTHS FROM THE "MAILING DATE noted below. Failure to timely comply will result in ABANDON THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		e a reply complying with the requirements	
5. A SUBSTITUTE OATH OR DECLARATION must be sub- INFORMAL PATENT APPLICATION (PTO-152) which gi			
 CORRECTED DRAWINGS (as "replacement sheets") muse (a) including changes required by the Notice of Draftspe 1) hereto or 2) to Paper No./Mail Date (b) including changes required by the attached Examine Paper No./Mail Date (beach sheet including changes). Identifying indicia such as the application number (see 37 CFR each sheet. Replacement sheet(s) should be labeled as such in 7. DEPOSIT OF and/or INFORMATION about the depattached Examiner's comment regarding REQUIREMENT 	rson's Patent Drawing Revier r's Amendment / Comment o 1.84(c)) should be written on t the header according to 37 CI osit of BIOLOGICAL MAT	r in the Office action of the drawings in the front (not the back) of R 1.121(d). ERIAL must be submitted. Note the	
 Attachment(s) 1. Notice of References Cited (PTO-892) 2. Notice of Draftperson's Patent Drawing Review (PTO-948) 3. Information Disclosure Statements (PTO-1449 or PTO/SB Paper No./Mail Date 7/22/03 4. Examiner's Comment Regarding Requirement for Deposit of Biological Material 	6. ⊠ Interview S Paper No. /08), 7. ⊠ Examiner's	formal Patent Application (PTO-152) ummary (PTO-413), /Mail Date Amendment/Comment Statement of Reasons for Allowance Jean Frantz Duverne	
		Primary Examiner Art Unit: 2839	

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DETAILED ACTION

EXAMINER'S AMENDMENT

1. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with Wei Te Chung on 6/11/2004.

The application has been amended as follows: Claims 1-5 have been canceled.

Reason for allowance

- 1. Claims 6-15 are allowed over the prior art.
- 2. The following is an examiner's statement of reasons for allowance: Prior art fails to disclose the plugs mating features inserting into the cavity with the elbow engaging the stopping tab, which is deflected upwardly allowing the mating plug to inserted into the cavity; the tab and the elbow arrangement in the cavity; however, when the second plug is inserted into the cavity, the stopping tab is struck thereby preventing the insertion; the mismatch devices defining a vertical dimension that is larger than that of the window in order for the tip of the elbow protectively hidden sideward behind the corresponding side and with the rest of the claims limitations. Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing

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delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jean F. Duverne whose telephone number is (571) 272-2091. The examiner can normally be reached on 9:00-7:30, Monday-Thursday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Lynn Feild can be reached on (571) 272-2092. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Any response to this action may be mailed to:
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

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For additional information regarding this new address, which was effective May 1, 2003, see Correspondence with the United States Patent and Trademark Office, 68 Fed. Reg. 14332 (March 25, 2003).

Or Faxed to:

(703) 872-9306.

JFD

06/12/2004

Jean Frantz Duverne

Primary Examiner

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